

SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2908-01L, S

SPEC. No. :

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1. Scope
This specifies Fuji power MOSFET 2SK2908-01L, S
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview T-Pack L-Type Outview See to 5/1 page
S-Type Outview See to 6/1 page
5. Absolute maximum ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	
Drain-source voltage	V_{DS}	600	V	
Continuous Drain current	I_D	± 9	A	
Pulsed drain current	I_{DPULSE}	± 32	A	
Gate-source voltage	V_{GS}	± 35	V	
Repetitive or non-repetitive	I_{AR}	9	V	Tch $\leq 150^\circ\text{C}$
Avalanche energy	E_{AS}	144.4	mJ	※
Maximum power dissipation	P_D	60	W	
Operating and storage temperature range	T_{ch}	150	$^\circ\text{C}$	
	T_{stg}	-55 ~ +150	$^\circ\text{C}$	

※ L=3.27mH、Vcc=60V

6. Electrical characteristics at Tc=25°C (unless otherwise specified)
- Static ratings

Description	Symbol	Conditions	Characteristics			Unit	
			Min.	Typ.	Max.		
Drain-source breakdown voltage	BV_{DSS}	$I_D = 1\text{mA}$ $V_{GS} = 0\text{V}$	600			V	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 1\text{mA}$ $V_{DS} = V_{GS}$	3.5	4.0	4.5	V	
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 600\text{V}$ $V_{GS} = 0\text{V}$	$T_{ch} = 25^\circ\text{C}$		10	500	μA
	I_{DSS}		$T_{ch} = 125^\circ\text{C}$		0.2	1.0	mA
Gate-source leakage current	I_{GSS}	$V_{GS} = \pm 35\text{V}$ $V_{DS} = 0\text{V}$		10	100	nA	
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 4.5\text{A}$ $V_{GS} = 10\text{V}$		1.0	1.2	Ω	

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Dynamic ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Forward transconductance	g_{fs}	$I_D = 4.5A$ $V_{DS} = 25V$	2.5	5.0		S
Input capacitance	C_{iss}	$V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$		900	1400	pF
Output capacitance	C_{oss}			150	230	pF
Reverse transfer capacitance	C_{rss}			70	110	pF
Turn-on time	$t_{d(on)}$	$V_{CC} = 300V$ $V_{GS} = 10V$ $I_D = 9A$ $R_{GS} = 10\Omega$		25	40	ns
	t_r			70	110	ns
Turn-off time	$t_{d(off)}$			60	90	ns
	t_f			35	60	ns

Reverse diode

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Avalanche capability	I_{AV}	$L = 3.27mH$, $T_{ch} = 25^\circ C$ *See Fig.1 and 2	9			A
Diode forward on-voltage	V_{SD}	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V$, $T_{ch} = 25^\circ C$		1.0	1.5	V
Reverse recovery time	t_{rr}	$I_F = I_{DR}$ $V_{GS} = 0V$ $-di_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$		550		ns
Reverse recovery charge	Q_{rr}				7.0	

7. Thermal resistance

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	$R_{th_{ch-c}}$				2.08	$^\circ C/W$
	$R_{th_{ch-a}}$				75.0	$^\circ C/W$

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Fig.1 Test circuit

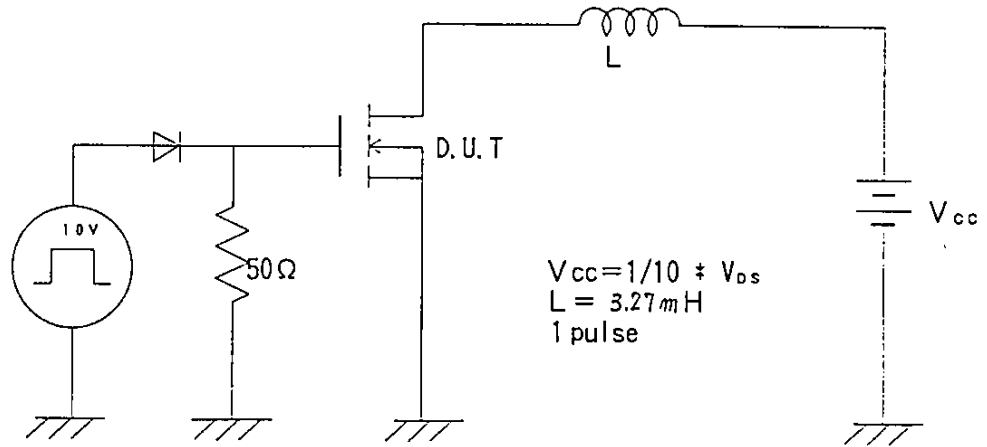
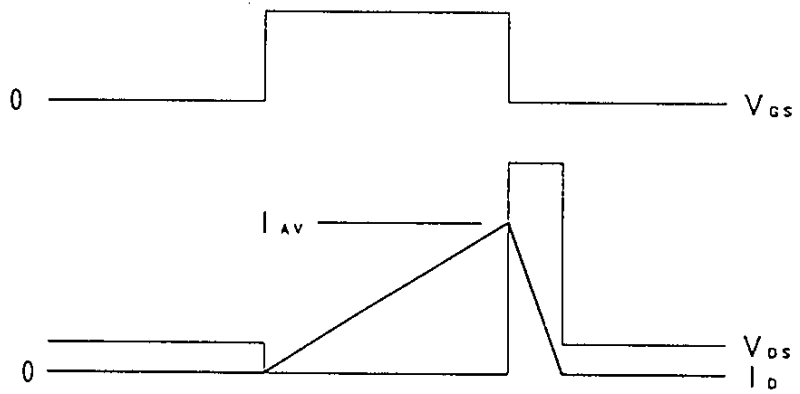


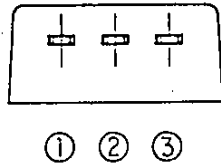
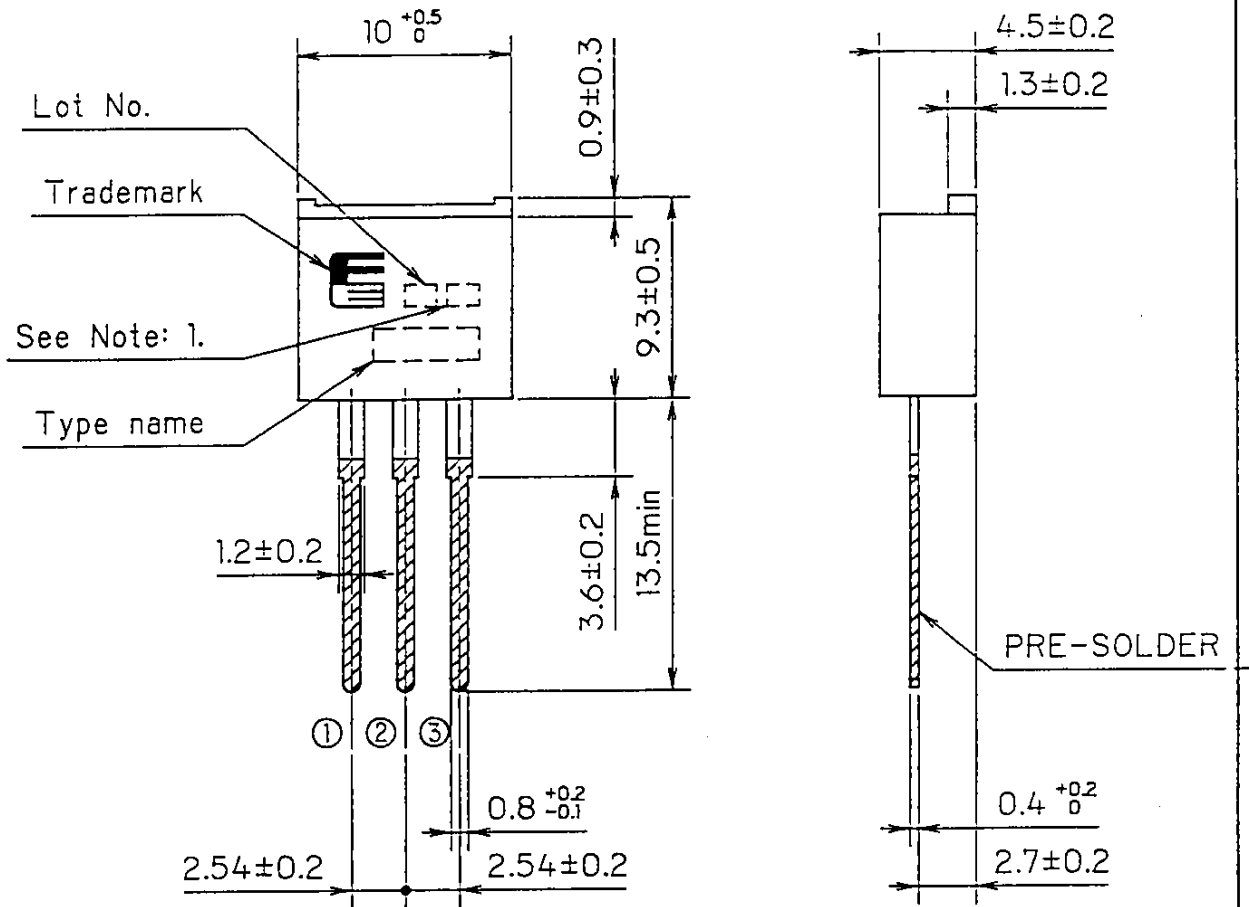
Fig.2 Operating waveforms



FUJI POWER MOS FET

TYPE : 2SK2908-01L

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CONNECTION

- ① GATE
- ② DRAIN
- ③ SOURCE

Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

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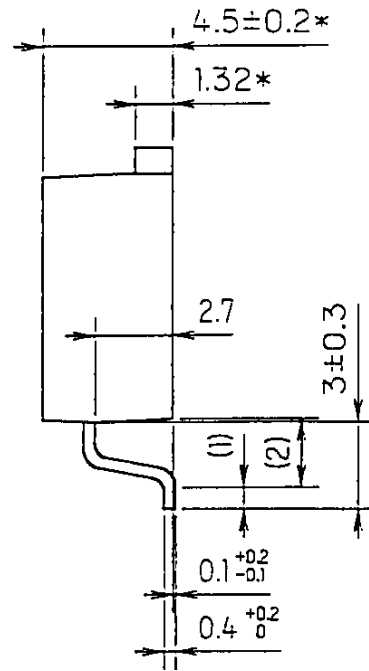
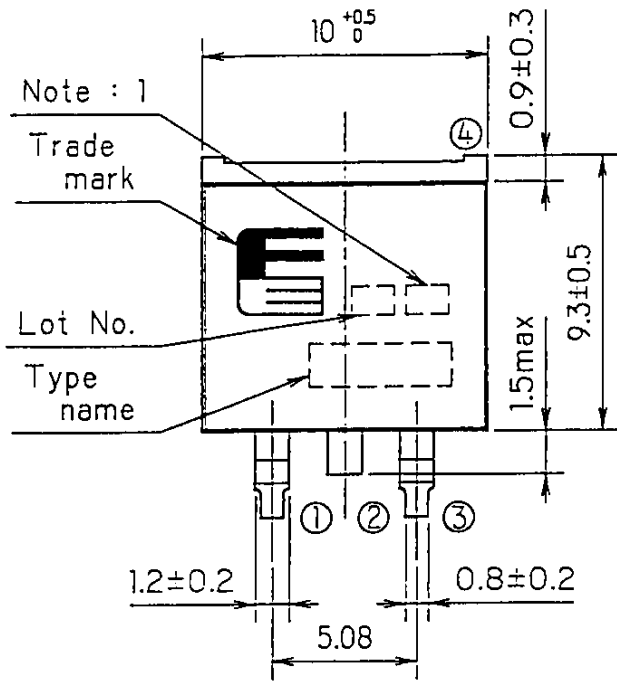
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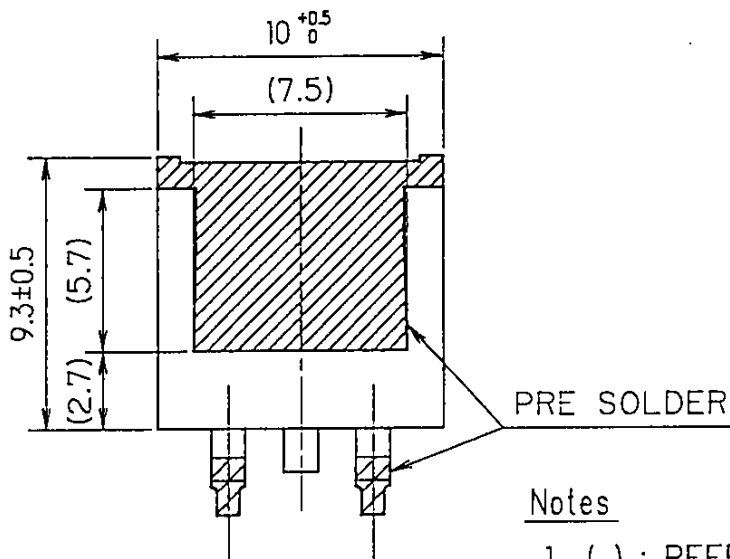
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FUJI POWER MOS FET

TYPE : 2SK2908-01S



BOTTOM VIEW



CONNECTION

- ① GATE
- ④ ② DRAIN
- ③ SOURCE

Notes

Note 1. Guaranteed mark of avalanche ruggedness.

- 1. () : REFERENCE DIMENSIONS.
- 2. * : DO NOT INCLUDE SOLDER.

DIMENSIONS ARE IN MILLIMETERS.

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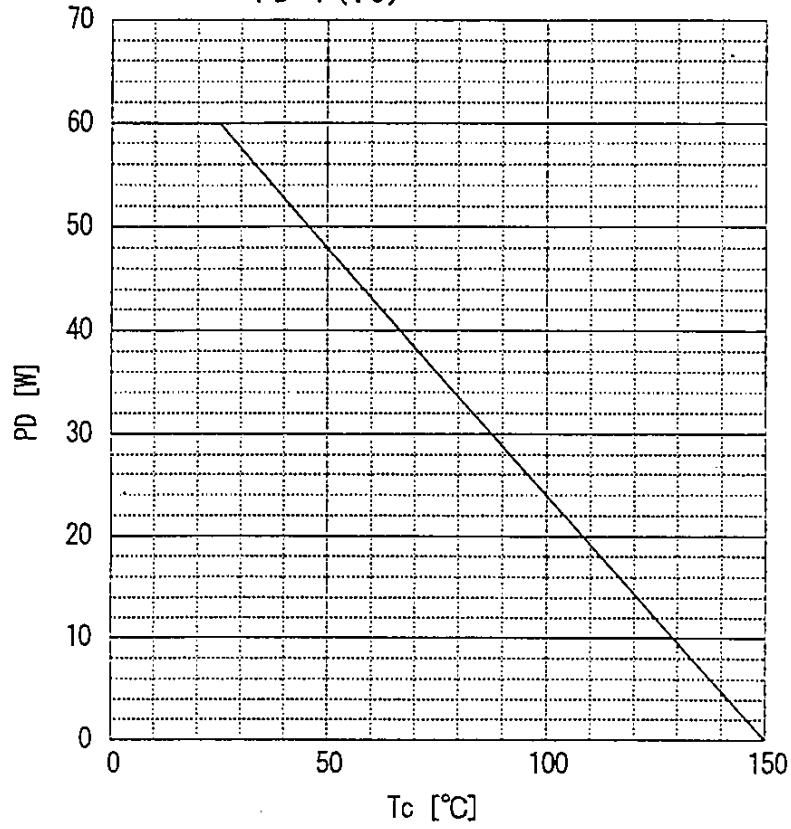
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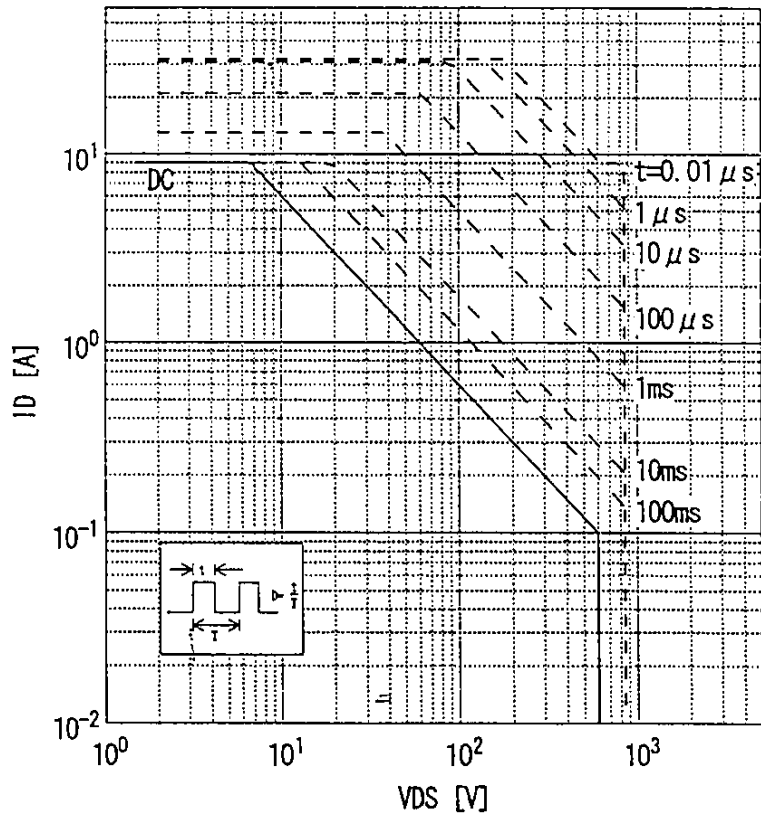
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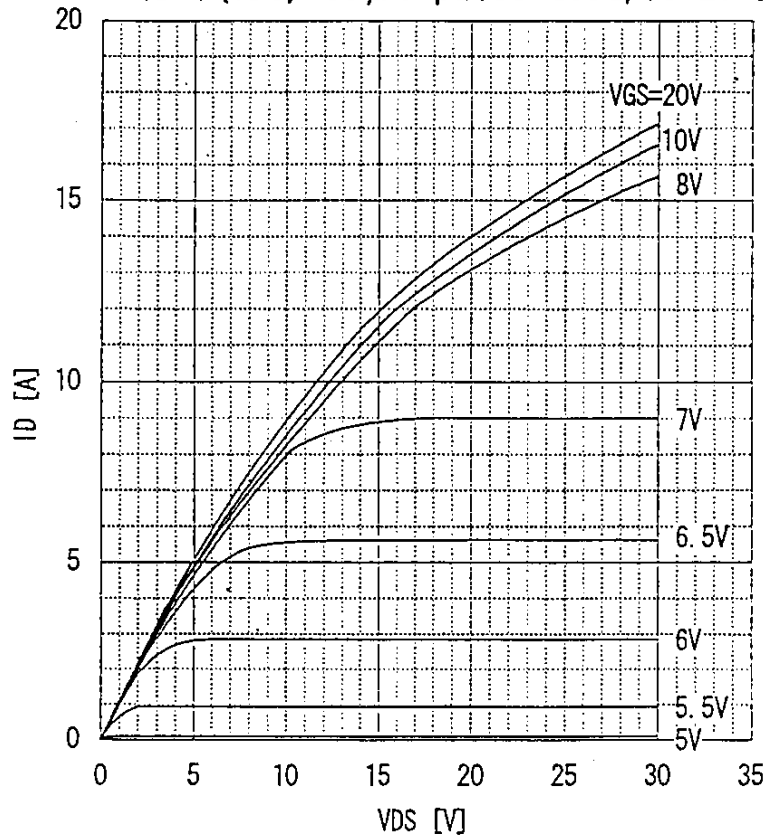
Power Dissipation
 $PD=f(T_c)$



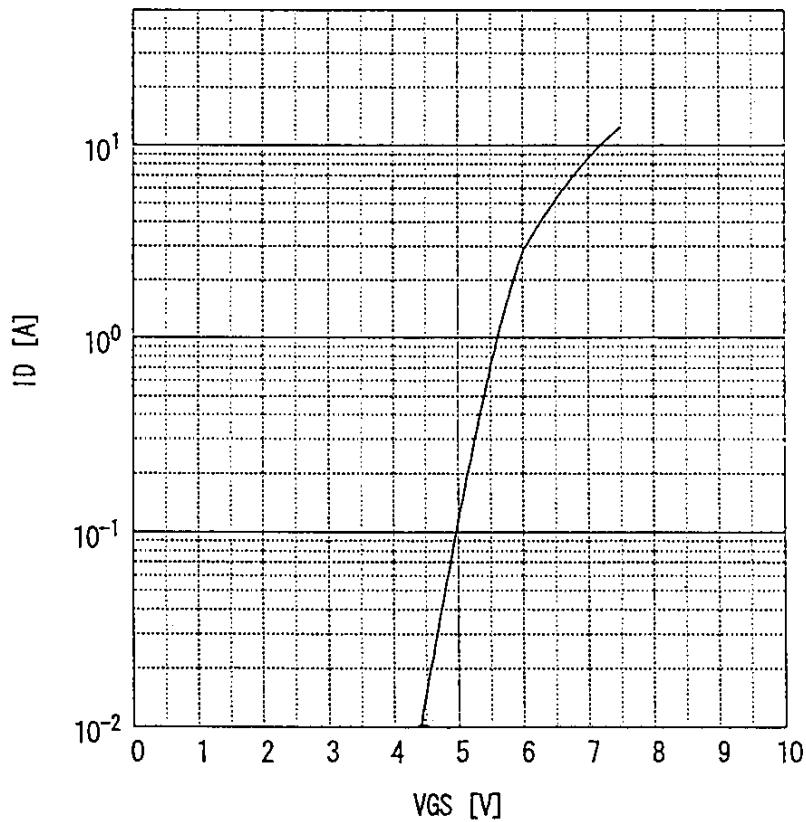
Safe operating area
 $ID=f(V_{DS}) : D=0.01, T_c=25^\circ\text{C}$



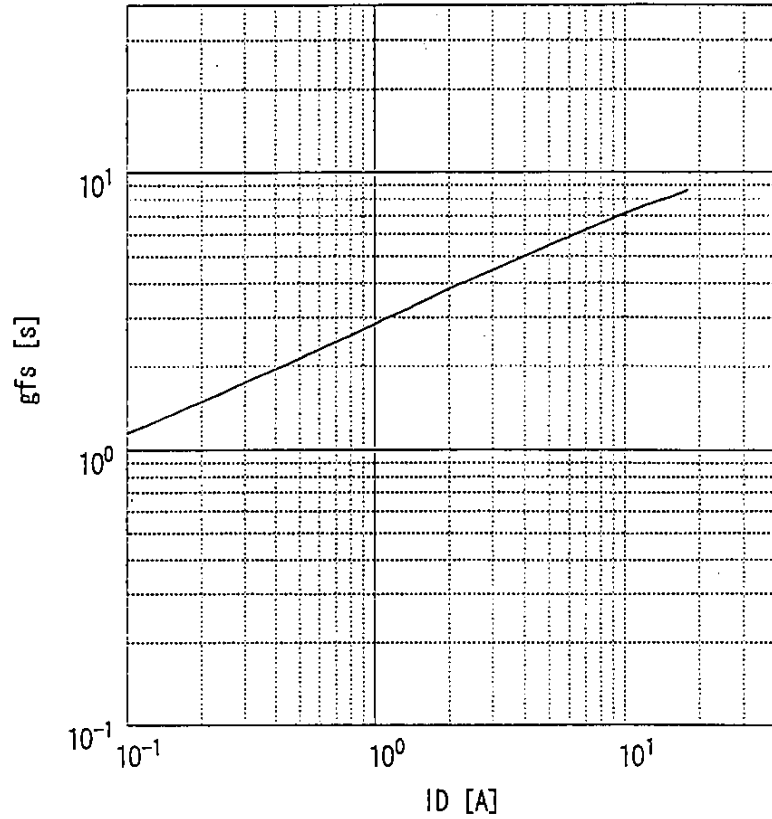
Typical output characteristics
 $I_D = f(V_{DS})$: 80 μ s pulse test, $T_c = 25^\circ\text{C}$



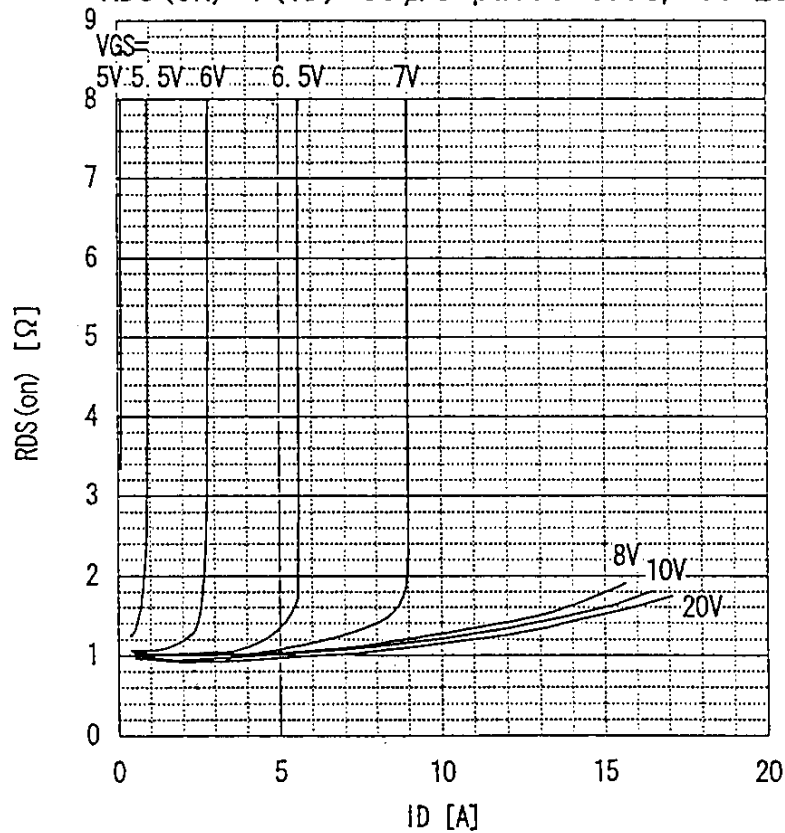
Typical transfer characteristic
 $I_D = f(V_{GS})$: 80 μ s pulse test, $V_{DS} = 25\text{V}$, $T_{ch} = 25^\circ\text{C}$



Typical forward transconductance
 $g_{fs}=f(I_D)$: 80 μ s pulse test, $V_{DS}=25V$, $T_{ch}=25^\circ C$

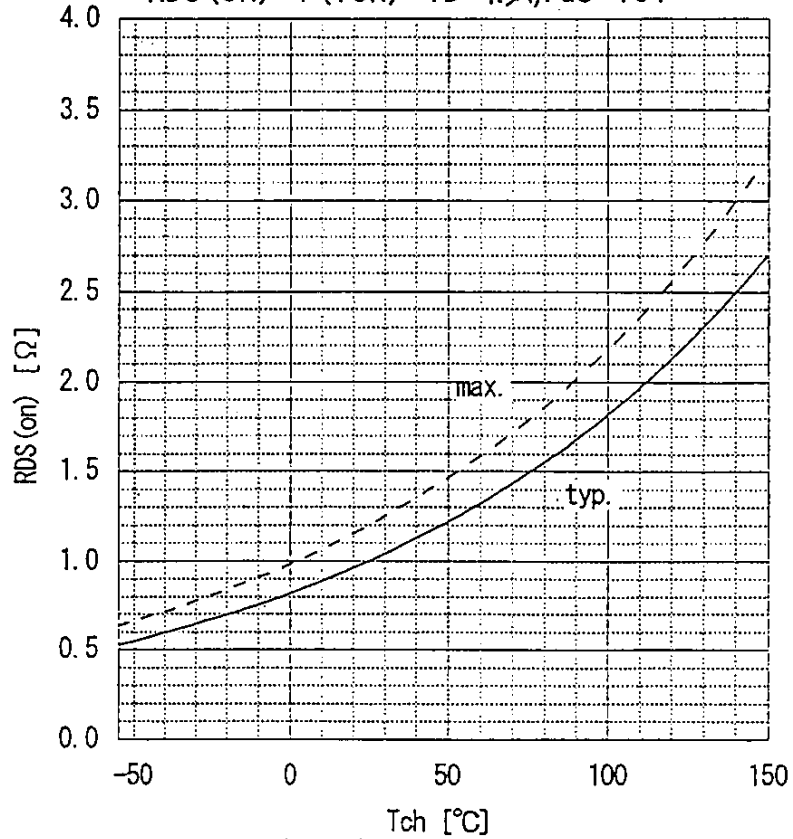


Typical drain-source on-state resistance
 $R_{DS(on)}=f(I_D)$: 80 μ s pulse test, $T_c=25^\circ C$



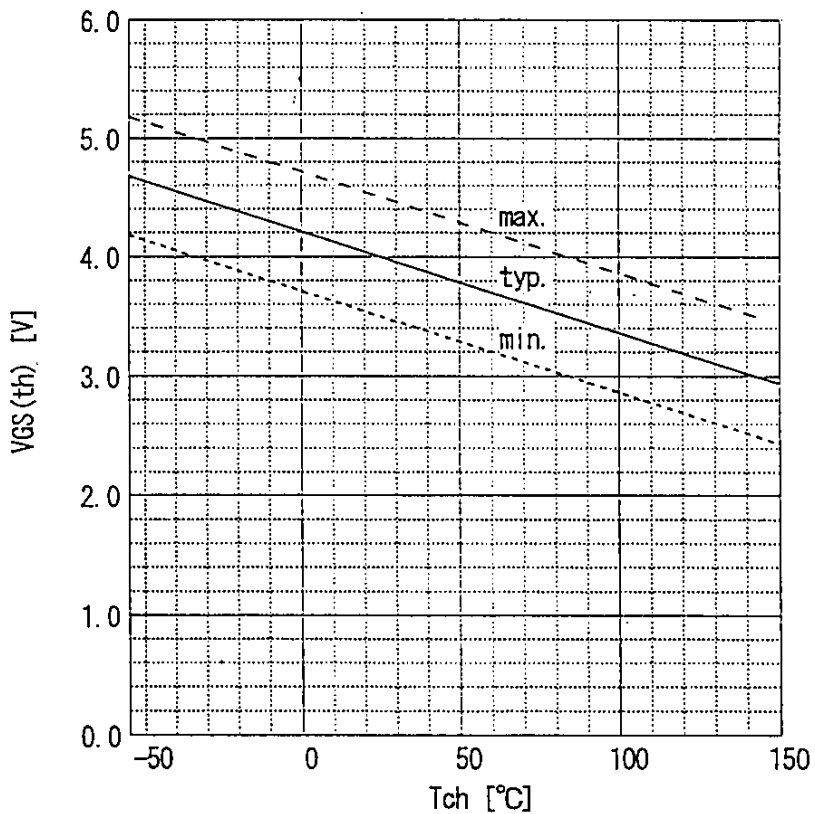
Drain-source on-state resistance

$R_{DS(on)} = f(T_{ch}) : I_D = 4.5A, V_{GS} = 10V$

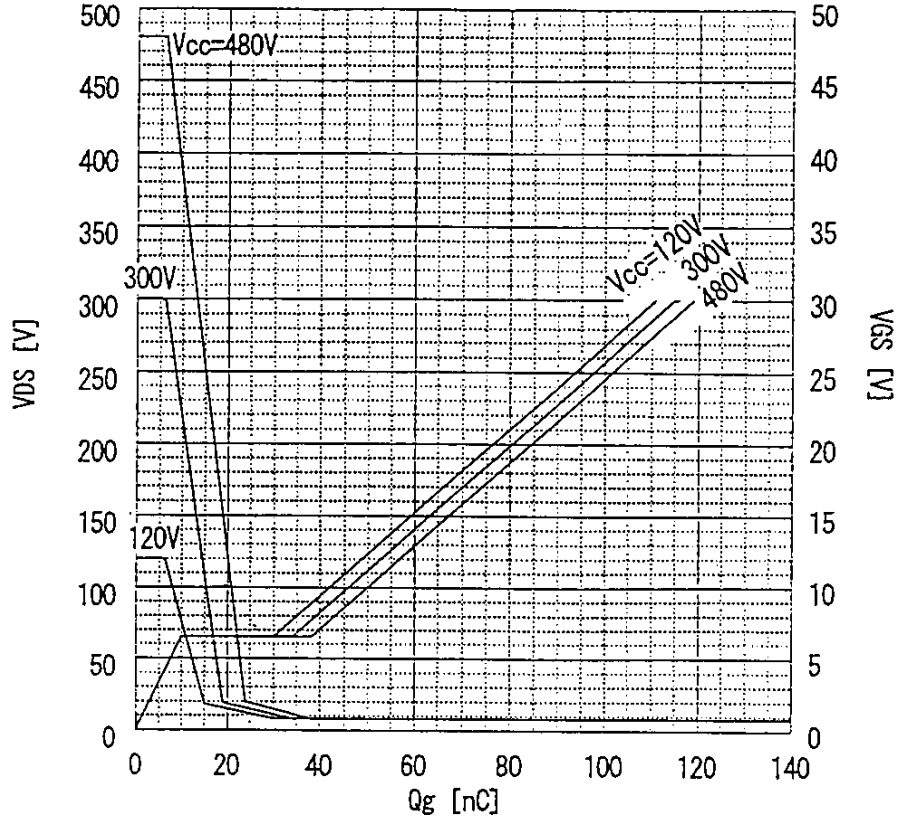


Gate threshold voltage

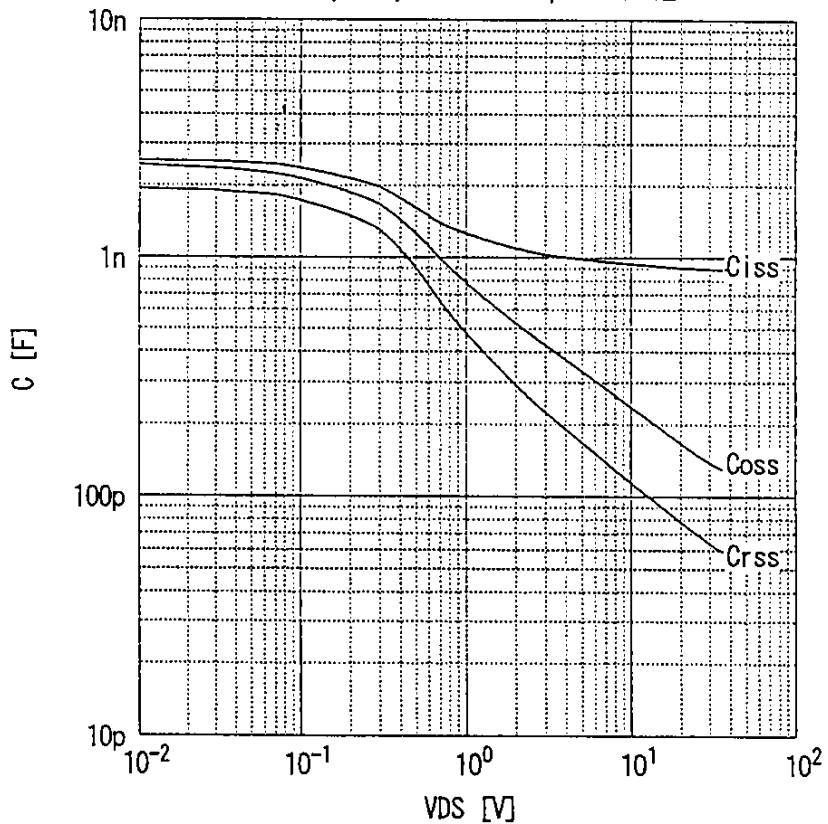
$V_{GS(th)} = f(T_{ch}) : I_D = 1mA, V_{DS} = V_{GS}$



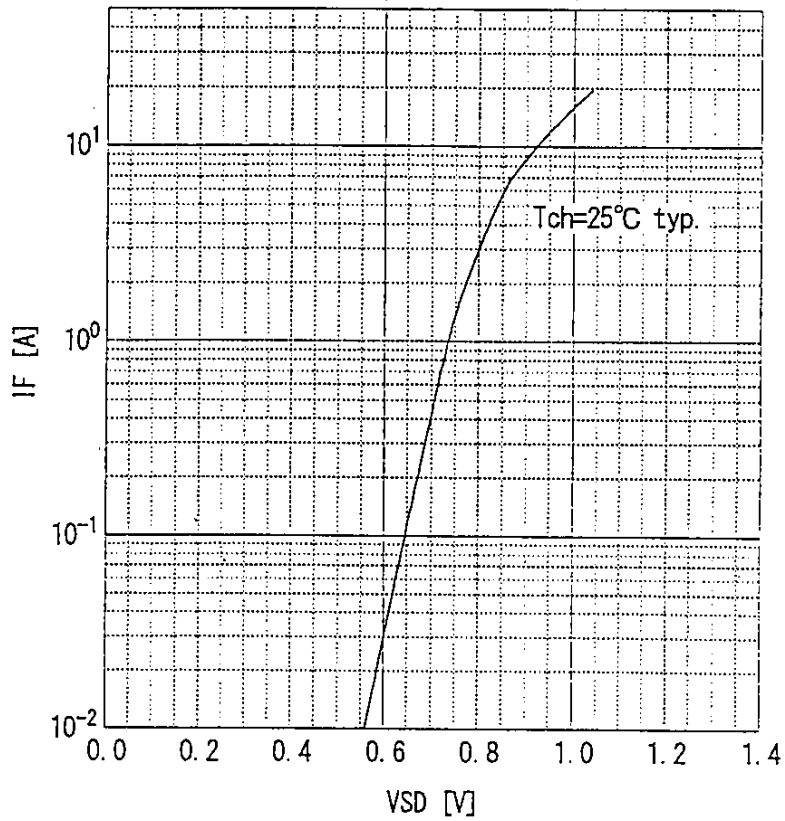
Typical gate charge characteristic
 $V_{GS} = f(Q_g) : I_D = 9A, T_c = 25^\circ C$



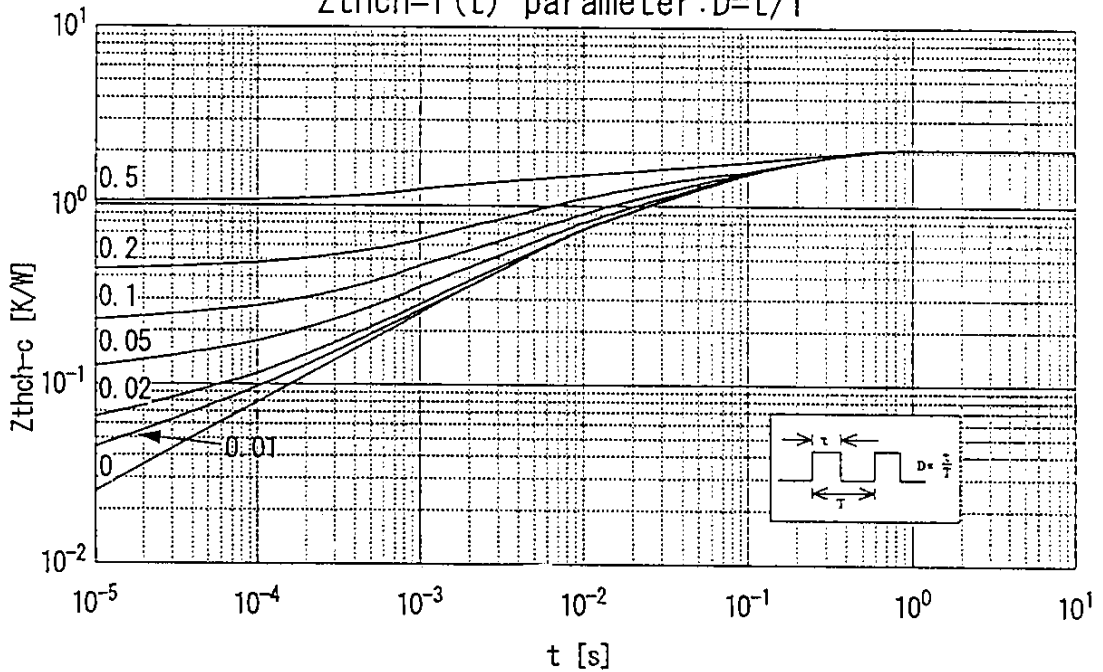
Typical capacitances
 $C = f(V_{DS}) : V_{GS} = 0V, f = 1MHz$



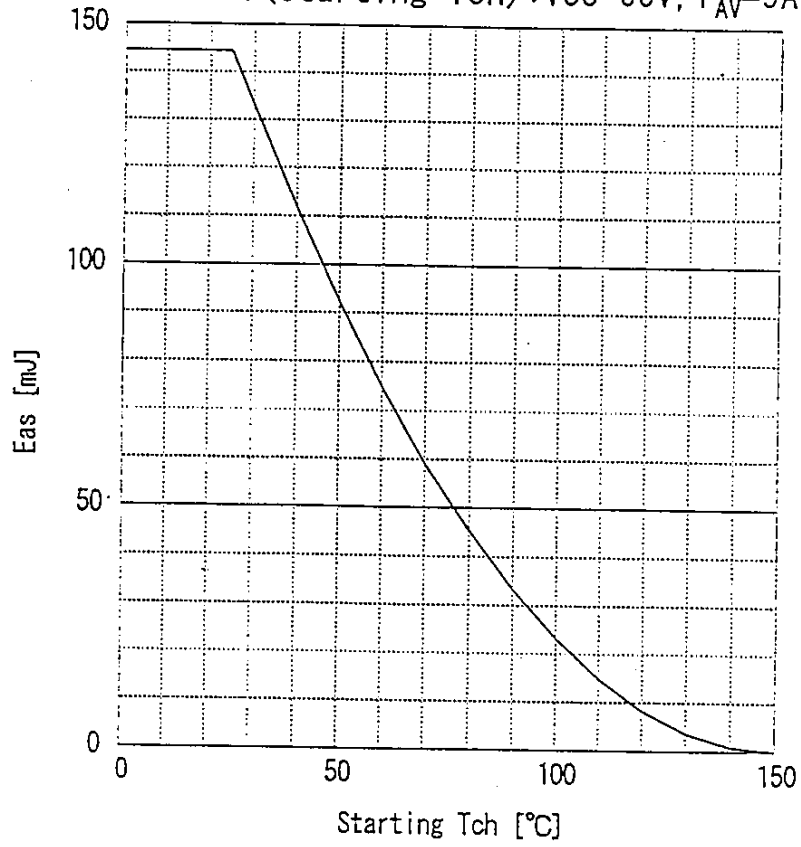
Forward characteristic of reverse of diode
 $I_F = f(V_{SD}) : 80 \mu s$ pulses test, $V_{GS} = 0V$



Transient thermal impedance
 $Z_{thch} = f(t)$ parameter: $D = t/T$



Avalanche energy derating
 $E_{as}=f(\text{starting } T_{ch}) : V_{cc}=60V, I_{AV}=9A$



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